Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/003,344	CHAE, YI SIK	
Examiner	Art Unit	

Thong H. Vu

SEARCHED					
Class	Subclass	Date	Examiner		
455	70,437, 414,436	6/19/2006	TV		
709	212	6/19/2006	TV		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST,NPL,IEEE	6/19/2006	τv	
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